

FORM PTO-1449 U.S. Department of Commerce (Rev. 4/92) Patent and Trademark Office	ATTY. DOCKET NO.	SERIAL NO.
	1113.40340X00	09/889,788
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	APPLICANT S. KOBAYASHI et al.	
(Use several sheets if necessary)	FILING DATE	GROUP
	September 26, 2001	2871

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER							DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>JMR</i>	4	3	4	5	2	4	9	08/82	Togashi	-----	-----	<i> </i>
<i>JMR</i>	5	5	7	6	8	6	7	11/96	Baur et al.	-----	-----	<i> </i>
<i>JMR</i>	5	5	9	8	2	8	5	01/97	Kondo et al.	-----	-----	<i> </i>

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER							DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION		
													YES	NO	
		6	3-	2	1	9	0	7	05/88	JP	-----	-----	X		
		9	1/	1	0	9	3	6	07/91	WO	-----	-----	Abstract		
		5-	2	6	5	0	0	6	10/93	JP	-----	-----	Abstract		
		6-	1	6	0	8	7	8	06/94	JP	-----	-----	Abstract		
		6-	2	2	2	3	9	7	08/94	JP	-----	-----	Abstract		
		7-	1	5	9	7	8	6	06/95	JP	-----	-----	Abstract		

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

 T. Sasaki et al., "An Analysis of Image-Sticking Effect by Transmittance Drift Measurement in Liquid Crystal Cells", Electronics and Communications in Japan, Part 2, Vol. 78, No. 2, 1995, pp. 79-85, ISSN 8756-663X/95/0002-0079 (in English), translated from Densi Joho Tsushin Gakkai Ronbunshi, Vol. 77-C-II, No. 9, September 1994, pp. 392-398 (in Japanese).

EXAMINER

 E. L. Rude

DATE CONSIDERED

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